## Notice of References Cited Application/Control No. 10/827,346 Examiner Steven Kau Applicant(s)/Patent Under Reexamination TANABE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,975,418	12-2005	Ohta et al.	358/1.15
*	В	US-2003/0025922	02-2003	Otsuki, Koichi	358/1.2
*	С	US-2004/0165199	08-2004	Klassen et al.	358/001.9
*	D	US-4,486,772	12-1984	Klie et al.	358/531
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-		·	
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	s					
	Т					·

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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